

High temperature thin film chip resistors

RGA series

AEC-Q200 Compliant

Features

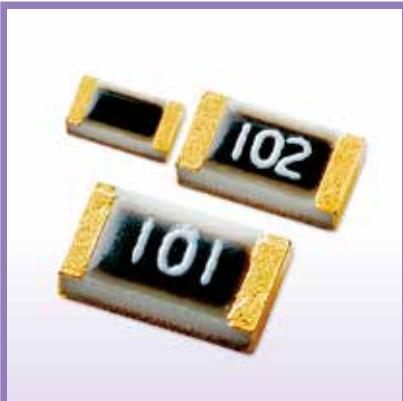
- Conductive epoxy compatible
- Operating temperature up to 230°C
- Resistance tolerance: ±0.1%, TCR: ±10ppm/°C
- Thin film structure enabling low noise and anti-sulfur

Applications

- Automotive electronics
- Equipment used in high temperature
- Downhole drilling

Thin film surface mount resistors

RGA series



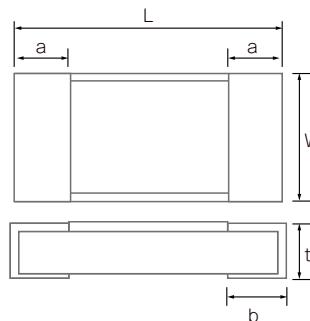
◆Part numbering system

Series code	RGA	2012	N - 104 - B - T1	Packaging quantity: T1(1,000pcs), T5(5,000pcs)
Size: RGA1005, RGA1608, RGA2012			Resistance tolerance	
Temperature coefficient of resistance			Nominal resistance value (E-24: 3digit, E-96: 4digit)	

◆Electrical Specification

Type	Power ratings	Temperature coefficient of resistance	Resistance range(Ω) Resistance tolerance		Maximum voltage	Resistance value series	Operating temperature	Packaging quantity			
		(ppm/°C)	±0.1% (B)	±0.5% (D)							
RGA1005	1/32W	±10(N)	47≤R≤100k		50V	E-24, E-96	-55°C ~ 230°C	T1 T5			
		±25(P)	10≤R≤100k								
RGA1608	1/16W	±10(N)	47≤R≤274k		100V						
		±25(P)	10≤R≤332k	10≤R≤360k							
RGA2012	1/10W	±10(N)	47≤R≤475k		150V						
		±25(P)	10≤R≤1M								

◆Dimensions



Type	Size (inch)	L	W	a	b	t
RGA1005	0402	1.00+0.1/-0.05	0.50±0.10	0.20±0.10	0.25±0.05	0.35±0.05
RGA1608	0603	1.60±0.20	0.80+0.25/-0.20	0.30±0.20	0.30±0.20	0.40+0.15/-0.10
RGA2012	0805	2.00±0.20	1.25+0.25/-0.20	0.40±0.20	0.40±0.20	0.40+0.15/-0.10

(unit : mm)

◆Reliability specification

Test items	Condition (test methods (MIL-PRF-55342/JIS C5201-1)	Standard
Short time overload	2.5 x rated voltage, ^{*1} 5seconds	±(0.1%+0.01Ω)
Life (biased)	125°C, rated voltage, ^{*1} 90min on 30min off, 1000hours	±(0.2%+0.05Ω)
High temperature high humidity	85°C, 85%RH, 1/10 of rated power, 90min on 30min off, 1000hours	±(0.2%+0.01Ω)
Temperature shock	-55°C (30min) ~ 125°C (30min) 1000cycles	±(0.2%+0.01Ω)
High temperature exposure	155°C, no bias, 1000hours	±(0.2%+0.05Ω)
Vibration	Frequency 10Hz ~ 500Hz, vibration amplitude 1.5mm or acceleration 10gn test duration for each of 3 axis: 6 hours	±(0.2%+0.05Ω)
Resistance to soldering heat	260±5°C, 10 seconds (reflow)	±(0.5%+0.01Ω)

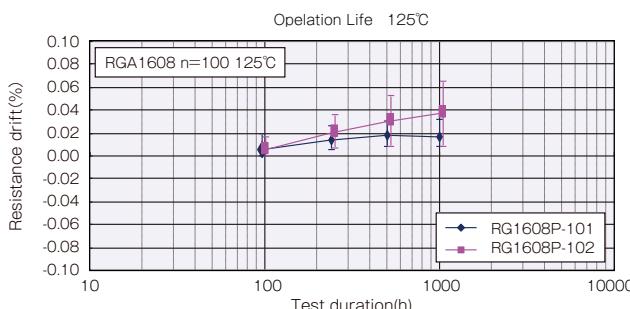
*1 Rated voltage is given by $E=\sqrt{R \times P}$

E= rated voltage (V), R=nominal resistance value(Ω), P=rated power(W)

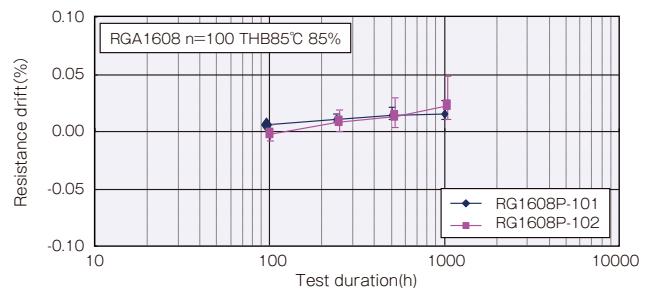
If rated voltage exceeds maximum voltage /element, maximum voltage/element is the rated voltage.

◆Reliability test data

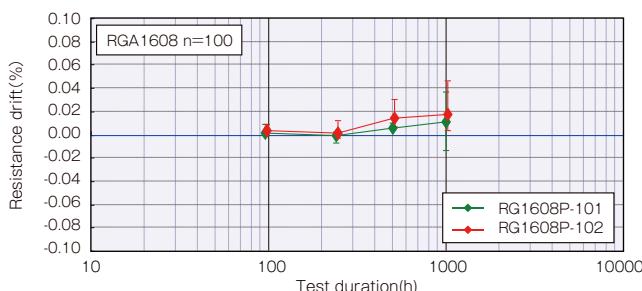
○Biased life test



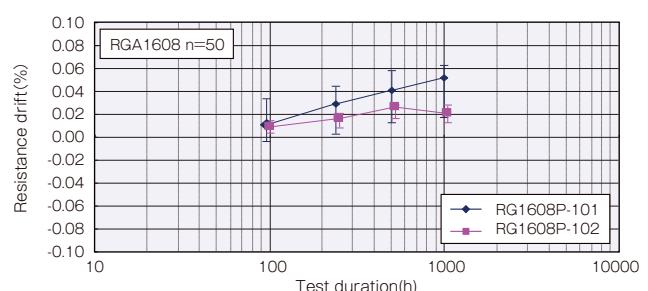
○High temperature high humidity (biased)



○Temperature shock



○High temperature exposure



◆Derating Curve

